Notice of References Cited

Application/Control No.

10/759,072

Examiner

Angela M. Lie

Applicant(s)/Patent Under
Reexamination
ONOZAWA ET AL.

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
,	Α	US-2001/0005188	06-2001	Watanabe, Takuya	345/60
	В	US-2002/0097203	07-2002	Onozawa et al.	345/67
	С	US-2001/0055258	12-2001	Carson et al.	369/59.12
	D	US-2002/0075746	06-2002	Ooishi, Tsukasa	365/230.03
	E	US-2002/0054001	05-2002	Awamoto, Kenji	345/60
	F	US-5,541,542	07-1996	Shibuya et al.	327/172
	G	US-5,471,171	11-1995	Itakura et al.	330/253
	Н	US-6,329,980	12-2001	Uehara et al.	345/204
	ı	US-5,311,169	05-1994	Inada et al.	. 345/77
•	J	US-			
	к	US-			
	L	US-		·	
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2001358570	12-2001	Japan	Hiroshi et al	C01B 33/12
	0			·		
	Р					,
	Q					
	R			·		
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.